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#### Boomer® Audio Power Amplifier Series Mono Class D and Stereo Audio Sub-System LM4947 with OCL Headphone Amplifier and National 3D

Check for Samples: LM4947, LM4947TLEVAL

## **FEATURES**

- I<sup>2</sup>C Control Interface
- I<sup>2</sup>C programmable National 3D Audio
- I<sup>2</sup>C controlled 32 step digital volume control (-59.5dB to +18dB)
- Three independent volume channels (Left, Right, Mono)
- Eight distinct output modes
- Small, 25-bump micro SMD packaging
- "Click and Pop" suppression circuitry

- Thermal shutdown protection
- Low shutdown current (0.1µA, typ) •
- **RF** suppression •
- Differential mono and stereo inputs
- Stereo input mux •

## APPLICATIONS

- **Mobile Phones**
- **PDAs**

## DESCRIPTION

The LM4947 is an audio subsystem capable of efficiently delivering 500mW (Class D operation) of continuous average power into a mono 8Ω bridged-tied load (BTL) with 1% THD+N, 37mW (Class AB operation) power channel of continuous average power into stereo 32Ω single-ended (SE) loads with 1% THD+N, or an output capacitor-less (OCL) configuration with identical specification as the SE configuration, from a 3.3V power supply.

The LM4947 has six input channels: one pair for a two-channel stereo signal, the second pair for a secondary two-channel stereo input, and the third pair for a differential single-channel mono input. Additionally, the two sets of stereo inputs may be configured as a single stereo differential input (differential left and differential right). The LM4947 features a 32-step digital volume control and eight distinct output modes. The digital volume control, 3D enhancement, and output modes are programmed through a two-wire I<sup>2</sup>C compatible interface that allows flexibility in routing and mixing audio channels.

The RF suppression circuitry in the LM4947 makes it well-suited for GSM mobile phones and other portable applications in which strong RF signals generated by an antenna (and long output traces) may couple audibly into the amplifier.

The LM4947 is designed for cellular phones, PDAs, and other portable handheld applications. It delivers high quality output power from a surface-mount package and requires only eight external components in the OCL mode (two additional components in SE mode).

#### Table 1. Key Specifications

	VALUE	UNIT
THD+N at 1kHz, 500mW into 8Ω BTL (3.3V)	1.0% (typ)	
THD+N at 1kHz, 37mW into 32Ω SE (3.3V)	1.0% (typ)	
Single Supply Operation (V <sub>DD</sub> )	2.7 to 5.5	V
I <sup>2</sup> C Single Supply Operation	2.2 to 5.5	V



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## **Typical Application**



Figure 1. Typical Audio Amplifier Application Circuit-Output Capacitor-less

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**Connection Diagram** 

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Figure 2. Typical Audio Amplifier Application Circuit-Single Ended



## Figure 3. 25-Bump micro SMD - Top View

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NOTE: XY - Date Code: TT - Die Traceability: G - Boomer Family: XX - H1

## Figure 4. micro SMD Marking - Top View

#### **Table 2. Pin Descriptions**

Name	Description
	Right Input Channel 2 or Right Differential Input –
	Left Input Channel 1 or Left Differential Input +
MIN+	Mono Channel Non-inverting Input
RHP <sub>3D1</sub>	Right Headphone 3D Input 1
	Right Headphone 3D Input 2
	Right Input Channel 1 or Right Differential Input +
	Left Input Channel 2 or Left Differential Input-
MIN-	Mono Channel Inverting Input
L <sub>HP3D1</sub>	Left Headphone 3D Input 2
L <sub>HP3D2</sub>	Left Headphone 3D Input 1
ADDR	Address Identification
SDA	Serial Data Input
SCL	Serial Clock Input
C <sub>BYPASS</sub>	Half-Supply Bypass Capacitor
VOC	Headphone return bias output
AV <sub>DD</sub>	Analog Power Supply
LSV <sub>DD</sub>	Loudspeaker Power Supply
I2CV <sub>DD</sub>	I2C Interface Power Supply
AV <sub>DD</sub>	Analog Power Supply
R <sub>HP</sub>	Right Headphone Output
LS-	Loudspeaker Output Negative
GND	Ground
LS+	Loudspeaker Output Positive
GND	Ground
L <sub>HP</sub>	Left Headphone Output
	RHP <sub>3D1</sub> RHP <sub>3D2</sub> R <sub>IN1</sub> L <sub>IN2</sub> MIN-           L <sub>HP3D1</sub> L <sub>HP3D2</sub> ADDR           SDA           SCL           C <sub>BYPASS</sub> VOC           AV <sub>DD</sub> LSV <sub>DD</sub> I2CV <sub>DD</sub> AV <sub>DD</sub> LS-           GND           LS+           GND



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



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## Absolute Maximum Ratings (1)

U U	
Supply Voltage	6.0V
Storage Temperature	−65°C to +150°C
Input Voltage	-0.3 to V <sub>DD</sub> +0.3
ESD Susceptibility <sup>(2)</sup>	2.0kV
ESD Machine model (3)	200V
Junction Temperature (T <sub>J</sub> )	150°C
Solder Information	
Vapor Phase (60 sec.)	215°C
Infrared (15 sec.)	220°C
Thermal Resistance	
θ <sub>JA</sub> (typ) - TLA25CBA	65°C/W

(1) Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

(2) Human body model, 100pF discharged through a  $1.5k\Omega$  resistor.

(3) Machine Model ESD test is covered by specification EIAJ IC-121-1981. A 200pF cap is charged to the specified voltage, then discharged directly into the IC with no external series resistor (resistance of discharge path must be under 50Ω).

## **Operating Ratings**

Temperature Range	−40°C to 85°C
Supply Voltage (V <sub>DD</sub> )	$2.7 V \le V_{DD} \le 5.5 V$
Supply Voltage (I <sup>2</sup> C)	$2.2V \le V_{DD} \le 5.5V$
Supply Voltage (Loudspeaker V <sub>DD</sub> )	$2.7V \le V_{DD} \le 5.5V$

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## Electrical Characteristics 3.3V (1) (2)

The following specifications apply for  $V_{DD}$  = 3.3V,  $T_A$  = 25°C, and all gains are set for 0dB unless otherwise specified.

Symbol	Parameter	Conditions	LM4	LM4947		
			Typical <sup>(3)</sup>	Limits (4)	(Limits)	
	Quiescont Cumply Current	Output Modes 2, 4, 6 $V_{IN} = 0V$ ; No load, OCL = 0 (Table 2)			mA (max)	
I <sub>DDQ</sub>	Quiescent Supply Current	Output Modes 1, 3, 5, 7 $V_{IN} = 0V$ ; No Ioad, BTL, OCL = 0 (Table 2)	6.5	8	mA (max)	
I <sub>SD</sub>	Shutdown Current	Output Mode 0	0.1	1	µA (max)	
\ <i>\</i>		V <sub>IN</sub> = 0V, Mode 7, Mono	2	15	mV (max)	
V <sub>OS</sub>	Output Offset Voltage	V <sub>IN</sub> = 0V, Mode 7, Headphones	2	15	mV (max)	
D	Output Power	$\begin{array}{l} \text{MONO}_{\text{OUT}}; \ \text{R}_{\text{L}} = 8\Omega \\ \text{THD+N} = 1\%; \ \text{f} = 1 \text{kHz}, \ \text{BTL}, \ \text{Mode} \ 1 \end{array}$	500	400	mW (min)	
P <sub>O</sub>	Output Power	$R_{OUT}$ and $L_{OUT};~R_L$ = 32 $\Omega$ THD+N = 1%; f = 1kHz, SE, Mode 4	37	33	mW (min)	
			0.03		%	
THD+N	Total Harmonic Distortion Plus Noise	$\label{eq:result} \begin{array}{l} R_{\text{OUT}} \text{ and } L_{\text{OUT}} \\ f = 1kHz,  P_{\text{OUT}} = 12mW; \\ R_{L} = 32\Omega,  SE,  Mode  4 \end{array}$	0.02		%	
		A-weighted, 0dB inputs terminated, output referred				
		Speaker; Mode 1	39		μV	
		Speaker; Mode 3	39		μV	
		Speaker; Mode 5	42		μV	
		Speaker; Mode 7	38		μV	
N <sub>OUT</sub>	Output Noise	Headphone; SE, Mode 2	15		μV	
		Headphone; SE, Mode 4	15		μV	
		Headphone; SE, Mode 6	17		μV	
		Headphone; OCL, Mode 2	12		μV	
		Headphone; OCL, Mode 4	15		μV	
		Headphone; OCL, Mode 6	17		μV	

(2) All voltages are measured with respect to the ground pin, unless otherwise specified.

- (3) Typical specifications are specified at +25°C and represent the most likely parametric norm.
- (4) Tested limits are guaranteed to National's AOQL (Average Outgoing Quality Level).

<sup>(1)</sup> Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.



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## www.ti.com Electrical Characteristics 3.3V <sup>(1) (2)</sup> (continued)

The following specifications apply for  $V_{DD} = 3.3V$ .  $T_A = 25^{\circ}C$ , and all gains are set for 0dB unless otherwise specified

Symbol	Parameter	Conditions	LM4	947	Units
			Typical <sup>(3)</sup>	Limits <sup>(4)</sup>	(Limits)
		$V_{RIPPLE} = 200mV_{PP}$ ; f = 217Hz, R <sub>L</sub> = 8 $\Omega$ , C <sub>B</sub> = 2.2 $\mu$ F, BTL All audio inputs terminated to GND; output referred			
	Power Supply Rejection Ratio Loudspeaker out	BTL, Output Mode 1	79		dB
		BTL, Output Mode 3	78		dB
		BTL, Output Mode 5	79		dB
		BTL, Output Mode 7	80		dB
PSRR		$V_{RIPPLE} = 200mV_{PP}$ ; f = 217Hz, R <sub>L</sub> = 32 $\Omega$ , C <sub>B</sub> = 2.2 $\mu$ F, BTL All audio inputs terminated to GND; output referred			
		SE, Output Mode 2	78		dB
	Power Supply Rejection Ratio	SE, Output Mode 4	71		dB
	COUT and COUT	SE, Output Mode 6	71		dB
		OCL, Output Mode 2	83		dB
		OCL, Output Mode 4	74		dB
		OCL, Output Mode 6	74		dB
η	Class D Efficiency	Output Mode 1, 3, 5	86		%
CMRR	Common-Mode-Rejection Ratio	$\label{eq:f_constraint} \begin{array}{l} f=217Hz, \ V_{CM}=1Vpp, \\ \mbox{Mode 1, BTL, } R_L=8\Omega \end{array}$	-49		dB
XTALK	Crosstalk	Headphone, $P_O = 12mW$ , f = 1kHz, OCL, Mode 4, $R_L = 32\Omega$	-58		dB
ATALK	CIUSSIAIK	Headphone, $P_O$ = 12mW, f = 1kHz, SE, Mode 4, $R_L$ = 32 $\Omega$	-73		dB
т	Wake-Up Time from Shutdown	$C_B = 2.2 \mu F$ , OCL, $R_L = 32 \Omega$	90		ms
T <sub>WU</sub>	Wake-op Time Hom Shudown	$C_B = 2.2 \mu F$ , SE, $R_L = 32 \Omega$	115		ms
	Volume Control Step Size Error		±0.2		dB
	Digital Volume Range	Input referred maximum attenuation	-59.5	-60.25 -58.75	dB (min) dB (max)
		Input referred maximum gain	+18	17.25 18.75	dB (min) dB (max)
	Mute Attenuation	Output Mode 1, 3, 5	87		dB (min)
	MONO_IN Input Impedance	Maximum gain setting	12	8 14	kΩ (min) kΩ (max)
	$R_{\rm IN}$ and $L_{\rm IN}$ Input Impedance	Maximum attenuation setting	100	75 125	kΩ (min) kΩ (max)



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## Electrical Characteristics 5V (1) (2)

The following specifications apply for  $V_{DD}$  = 5V,  $T_A$  = 25°C and all gains are set for 0dB unless otherwise specified.

Symbol	Parameter	Conditions	LM4	LM4947		
			Typical <sup>(3)</sup>	Limits <sup>(4)</sup>	(Limits)	
1	Quiescent Supply Current	Output Modes 2, 4, 6 V <sub>IN</sub> = 0V; No load, OCL = 0 (Table 2)	5.4	7.5	mA	
I <sub>DDQ</sub>	Quescent Supply Current	Output Modes 1, 3, 5, 7 $V_{IN} = 0V$ ; No load, BTL, OCL = 0 (Table 2)	7.6	12	mA	
I <sub>SD</sub>	Shutdown Current	Output Mode 0	0.1	1	µA (max)	
		V <sub>IN</sub> = 0V, Mode 7, Mono	2	15	mV (max)	
V <sub>OS</sub>	Output Offset Voltage	$V_{IN} = 0V$ , Mode 7, Headphones	2	15	mV (max)	
Po	Output Power	$\begin{array}{l} \text{MONO}_{\text{OUT}}; \ \text{R}_{\text{L}} = 8\Omega \\ \text{THD+N} = 1\%; \ \text{f} = 1 \text{kHz}, \ \text{BTL}, \ \text{Mode} \ 1 \end{array}$	1.19		W	
		$R_{OUT}$ and $L_{OUT}; R_L$ = 32 $\Omega$ THD+N = 1%; f = 1kHz, SE, Mode 4	87		mW	
	Total Harmonic Distortion + Noise	$ \begin{array}{l} \text{MONO}_{\text{OUT}} \\ \text{f} = 1 \text{kHz}, \ \text{P}_{\text{OUT}} = 500 \text{mW}; \\ \text{R}_{\text{L}} = 8 \Omega, \ \text{BTL}, \ \text{Mode} \ 1 \end{array} $	0.04		%	
THD+N	Total Harmonic Distortion + Noise	$R_{OUT}$ and $L_{OUT}$ f = 1kHz, $P_{OUT}$ = 30mW; $R_{L}$ = 32 $\Omega$ , SE, Mode 4	0.01		%	
		A-weighted, 0dB inputs terminated, output referred				
		Speaker; Mode 1	38		μV	
		Speaker; Mode 3	38		μV	
		Speaker; Mode 5	39		μV	
		Speaker; Mode 7	36		μV	
N <sub>OUT</sub>	Output Noise	Headphone; SE, Mode 2	21		μV	
		Headphone; SE, Mode 4	21		μV	
		Headphone; SE, Mode 6	24		μV	
		Headphone; OCL, Mode 2	16		μV	
		Headphone; OCL, Mode 4	16		μV	
		Headphone; OCL, Mode 6	19		μV	

(2) All voltages are measured with respect to the ground pin, unless otherwise specified.

(4) Tested limits are guaranteed to National's AOQL (Average Outgoing Quality Level).

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<sup>(1)</sup> Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

<sup>(3)</sup> Typical specifications are specified at +25°C and represent the most likely parametric norm.



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# Electrical Characteristics 5V <sup>(1) (2)</sup> (continued)

The following specifications apply for  $V_{DD} = 5V$ ,  $T_A = 25^{\circ}C$  and all gains are set for 0dB unless otherwise specified.

Symbol	Parameter	Conditions	LM4	947	Units
			Typical <sup>(3)</sup>	Limits <sup>(4)</sup>	(Limits)
		$ \begin{array}{l} V_{RIPPLE} = 200mV_{PP}; \ f = 217Hz, \\ R_L = 8\Omega, \ C_B = 2.2\mu F, \ BTL \\ All \ audio \ inputs \ terminated \ to \ GND; \\ output \ referred \end{array} $			
	Power Supply Rejection Ratio	BTL, Output Mode 1	70		dB
		BTL, Output Mode 3	61		dB
		BTL, Output Mode 5	64		dB
		BTL, Output Mode 7	61		dB
PSRR		$V_{RIPPLE} = 200mV_{PP}$ ; f = 217Hz, R <sub>L</sub> = 32 $\Omega$ , C <sub>B</sub> = 2.2 $\mu$ F, BTL All audio inputs terminated to GND; output referred			
		SE, Output Mode 2	72		dB
	Power Supply Rejection Ratio $R_{OUT}$ and $L_{OUT}$	SE, Output Mode 4	70		dB
		SE, Output Mode 6	65		dB
		OCL, Output Mode 2	76		dB
		OCL, Output Mode 4	72		dB
		OCL, Output Mode 6	70		dB
η	Class D Efficiency	Output Mode 1, 3, 5	86		%
CMRR	Common-Mode Rejection Ratio	f = 1kHz, V <sub>CM</sub> = 1Vpp, 0dB gain, Mode 1, BTL, R <sub>L</sub> = 8 $\Omega$	-49		dB
VTALK	Createlle	Headphone, $P_O = 30mW$ , f = 1kHz, OCL, Mode 4	-55		dB
XTALK	Crosstalk	Headphone, $P_O = 30mW$ , f = 1kHz, SE, Mode 4	-72		dB
<b>-</b>	Wake Up Time from Chutdown	$C_B = 2.2 \mu F$ , OCL, $R_L = 32 \Omega$	116		ms
T <sub>WU</sub>	Wake-Up Time from Shutdown	$C_B = 2.2 \mu F$ , SE, $R_L = 32 \Omega$	150		ms
	Volume Control Step Size Error		±0.2		dB
	Digital Valuma Paras	Input referred maximum attenuation	-59.5		dB
	Digital Volume Range	Input referred maximum gain	+18		dB
	Mute Attenuation	Output Mode 1, 3, 5	90		dB (min)
	MONO_IN Input Impedance	Maximum gain setting	11		kΩ (min) kΩ (max)
	R <sub>IN</sub> and L <sub>IN</sub> Input Impedance	Maximum attenuation setting	100		kΩ (min) kΩ (max)

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## I<sup>2</sup>C <sup>(1)</sup> <sup>(2)</sup>

The following specifications apply for  $V_{DD}$  = 5V and 3.3V,  $T_A$  = 25°C unless otherwise specified.

Symb	Parameter	Conditions	LM4	Units	
ol			Typical <sup>(3)</sup>	Limits	(Limits)
t <sub>1</sub>	Clock Period			2.5	µs (max)
t <sub>2</sub>	Clock Setup Time			100	ns (min)
t <sub>3</sub>	Data Hold Time			100	ns (min)
t <sub>4</sub>	Start Condition Time			100	ns (min)
t <sub>5</sub>	Stop Condition Time			100	ns (min)
V <sub>IH</sub>	SPI Input Voltage High			0.7xl <sup>2</sup> C V <sub>DD</sub>	V (min)
V <sub>IL</sub>	SPI Input Voltage Low			0.3xl <sup>2</sup> C V <sub>DD</sub>	V (max)

(1) Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

(2) All voltages are measured with respect to the ground pin, unless otherwise specified.

(3) Typical specifications are specified at +25°C and represent the most likely parametric norm.

(4) Tested limits are guaranteed to National's AOQL (Average Outgoing Quality Level).

## I<sup>2</sup>C Protocol Information

The I<sup>2</sup>C address for the LM4947 is determined using the ID\_ENB pin. The LM4947's two possible I<sup>2</sup>C chip addresses are of the form 111110X<sub>1</sub>0 (binary), where  $X_1 = 0$ , if ID\_ADDR is logic LOW; and  $X_1 = 1$ , if ID\_ENB is logic HIGH. If the I<sup>2</sup>C interface is used to address a number of chips in a system, the LM4947's chip address can be changed to avoid any possible address conflicts.



Figure 6. I<sup>2</sup>C Timing Diagram







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50m 100m

50m 100m

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5k 10k 20k

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FREQUENCY (Hz)  $V_{DD} = 3.3V, R_L = 32\Omega, P_O = 12mW$ 5k 10k 20k FREQUENCY (Hz)  $V_{DD} = 3.3V, R_L = 32\Omega, P_O = 12mW$ Mode 4,7, OCL 5k 10k 20k FREQUENCY (Hz)

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EXAS

Instruments

10

5

2

1

0.5

0.2

0.1

0.05

0.02

0.01

0.005

0.002

0.001

10

5

2

1

0.5

0.2

0.1

0.05

0.02

0.01

0.005

0.002

0.001 20

THD + N (%)

20

THD + N (%)

THD+N

vs

Frequency

Mode 4,7, SE

2k

FREQUENCY (Hz)

THD+N

vs

Frequency

Mode 6, SE

50 100 200 500 1k 2k

FREQUENCY (Hz)

50 100 200 500 1k



10

5

2

1

0.5

0.2

0.1 0.05

0.02

0.01

0.005

0.002

0.001

20

THD + N (%)





Diff In, Mode 5

FREQUENCY (Hz)

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FREQUENCY (Hz)

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OUTPUT POWER (mW)

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OUTPUT POWER (mW)





40

40

50

50



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1600



120

100

5k 10k 20k

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22

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5k 10k 20k



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#### **Application Information**

## I<sup>2</sup>C PIN DESCRIPTION

SDA: This is the serial data input pin.

SCL: This is the clock input pin.

ID\_ENB: This is the address select input pin.

## I<sup>2</sup>C COMPATIBLE INTERFACE

The LM4947 uses a serial bus which conforms to the  $I^2C$  protocol to control the chip's functions with two wires: clock (SCL) and data (SDA). The clock line is uni-directional. The data line is bi-directional (open-collector). The maximum clock frequency specified by the  $I^2C$  standard is 400kHz. In this discussion, the master is the controlling microcontroller and the slave is the LM4947.

The I<sup>2</sup>C address for the LM4947 is determined using the ID\_ENB pin. The LM4947's two possible I<sup>2</sup>C chip addresses are of the form 111110X<sub>1</sub>0 (binary), where  $X_1 = 0$ , if ID\_ADDR is logic LOW; and  $X_1 = 1$ , if ID\_ENB is logic HIGH. If the I<sup>2</sup>C interface is used to address a number of chips in a system, the LM4947's chip address can be changed to avoid any possible address conflicts.

The bus format for the I<sup>2</sup>C interface is shown in Figure 3. The bus format diagram is broken up into six major sections:

The "start" signal is generated by lowering the data signal while the clock signal is HIGH. The start signal will alert all devices attached to the I<sup>2</sup>C bus to check the incoming address against their own address.

The 8-bit chip address is sent next, most significant bit first. The data is latched in on the rising edge of the clock. Each address bit must be stable while the clock level is HIGH.

After the last bit of the address bit is sent, the master releases the data line HIGH (through a pull-up resistor). Then the master sends an acknowledge clock pulse. If the LM4947 has received the address correctly, then it holds the data line LOW during the clock pulse. If the data line is not held LOW during the acknowledge clock pulse, then the master should abort the rest of the data transfer to the LM4947.

The 8 bits of data are sent next, most significant bit first. Each data bit should be valid while the clock level is stable HIGH.

After the data byte is sent, the master must check for another acknowledge to see if the LM4947 received the data.

The "stop" signal ends the transfer. To signal "stop", the data signal goes HIGH while the clock signal is HIGH. The data line should be held HIGH when not in use.

## I<sup>2</sup>C INTERFACE POWER SUPPLY PIN (I<sup>2</sup>CV<sub>DD</sub>)

The LM4947's  $I^2C$  interface is powered up through the  $I^2CV_{DD}$  pin. The LM4947's  $I^2C$  interface operates at a voltage level set by the  $I^2CV_{DD}$  pin which can be set independent to that of the main power supply pin  $V_{DD}$ . This is ideal whenever logic levels for the  $I^2C$  interface are dictated by a microcontroller or microprocessor that is operating at a lower supply voltage than the main battery of a portable system.

				-				
	A7	A6	A5	A4	A3	A2	A1	A0
Chip Address	1	1	1	1	1	0	EC	0
$ID_ADDR = 0$	1	1	1	1	1	0	0	0
ID_ADDR = 1	1	1	1	1	1	0	1	0

#### Table 3. Chip Address

#### Table 4. Control Registers

	D7	D6	D5	D4	D3	D2	D1	D0
Mode Control	0	0	SE/Diff (select)	0	OCL (select)	MC2	MC1	MC0

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Table 4. Control Registers (Continued)										
	D7	D6	D5	D4	D3	D2	D1	D0		
Programmable 3D	0	1	L2R2 (select)	L1R1 (select)	N3D3	N3D2	N3D1	N3D0		
Mono Volume Control	1	0	0	MVC4	MVC3	MVC2	MVC1	MVC0		
Left Volume Control	1	1	0	LVC4	LVC3	LVC2	LVC1	LVC0		
Right Volume Control	1	1	1	RVC4	RVC3	RVC2	RVC1	RVC0		

## Table 4. Control Registers (continued)

## Table 5. Programmable National 3D Audio

	N3D3	N3D2
Low	0	0
Medium	0	1
High	1	0
Maximum	1	1

## Table 6. Input/Output Control

	L2R2	L1R1	SE/DIFF
Select L <sub>IN1</sub> and R <sub>IN1</sub> Stereo Pair	0	1	0
Select L <sub>IN2</sub> and R <sub>IN2</sub> Stereo Pair	1	0	0
Select $L_{IN1}+L_{IN2}$ and $R_{IN1}+R_{IN2}$ Stereo Pair	1	1	0
Sets Stereo Inputs to Differential	x	х	1

## Table 7. Output Volume Control Table

Volume Step	xVC4	xVC3	xVC2	xVC1	xVC0	Gain, dB
1	0 0		0 0 0		0	-59.50
2	0	0	0	0	1	-48.00
3	0	0	0	1	0	-40.50
4	0	0	0	1	1	-34.50
5	0	0	1	0	0	-30.00
6	0	0	1	0	1	-27.00
7	0	0	1	1	0	-24.00
8	0	0	1	1	1	-21.00
9	0	1	0	0	0	-18.00
10	0	1	0	0	1	-15.00
11	0	1	0	1	0	-13.50
12	0	1	0	1	1	-12.00
13	0	1	1	0	0	-10.50
14	0	1	1	0	1	-9.00
15	0	1	1	1	0	-7.50
16	0	1	1	1	1	-6.00
17	1	0	0	0	0	-4.50
18	1	0	0	0	1	-3.00
19	1	0	0	1	0	-1.50
20	1	0	0	1	1	0.00
21	1	0	1	0	0	1.50
22	1	0	1	0	1	3.00
23	1	0	1	1	0	4.50
24	1	0	1	1	1	6.00
25	1	1	0	0	0	7.50

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STRUMENTS

Volume Step	xVC4	xVC3	xVC2	xVC1	xVC0	Gain, dB
26	1	1	0	0	1	9.00
27	1	1	0	1	0	10.50
28	1	1	0	1	1	12.00
29	1	1	1	0	0	13.50
30	1	1	1	0	1	15.00
31	1	1	1	1	0	16.50
32	1	1	1	1	1	18.00

## Table 7. Output Volume Control Table (continued)

## Table 8. Output Mode Selection

Output Mode Number	MC2	MC1	MC0	Handsfree Mono Output	Right HP Output	Left HP Output
0	0	0	0	SD	SD	SD
1	0	0	1	2 x G <sub>M</sub> x M	2 x G <sub>M</sub> x M MUTE	
2	0	1	0	SD	G <sub>M</sub> x M	G <sub>M</sub> x M
3	0	1	1	G <sub>L</sub> x L + G <sub>R</sub> x R	MUTE	MUTE
4	1	0	0	SD	G <sub>R</sub> x R	G <sub>L</sub> x L
5	1	0	1	$G_L \times L + G_R \times R + 2(G_M \times M)$	MUTE	MUTE
6	1	1	0	SD	G <sub>R</sub> x R + G <sub>M</sub> x M	G <sub>L</sub> x L + G <sub>M</sub> x M
7	1	1	1	G <sub>R</sub> x R + G <sub>L</sub> x L	G <sub>R</sub> x R	G <sub>L</sub> x L

## NATIONAL 3D ENHANCEMENT

The LM4947 features a stereo headphone, 3D audio enhancement effect that widens the perceived soundstage from a stereo audio signal. The 3D audio enhancement creates a perceived spatial effect optimized for stereo headphone listening. The LM4947 can be programmed for a "narrow" or "wide" soundstage perception. The narrow soundstage has a more focused approaching sound direction, while the wide soundstage has a spatial, theater-like effect. Within each of these two modes, four discrete levels of 3D effect that can be programmed: low, medium, high, and maximum (Table 2), each level with an ever increasing aural effect, respectively. The difference between each level is 3dB.

The external capacitors, shown in Figure 6, are required to enable the 3D effect. The value of the capacitors set the cutoff frequency of the 3D effect, as shown by Equations 1 and 2. Note that the internal  $20k\Omega$  resistor is nominal (±25%).



Figure 7. External 3D Effect Capacitors

 $f_{\text{3DL(-3dB)}} = 1 \ / \ 2\pi \ ^* \ 20k\Omega \ ^* \ C_{\text{3DL}}$ 

 $f_{3DR(-3dB)} = 1 / 2\pi * 20k\Omega * C_{3DR}$ 

Optional resistors  $R_{3DL}$  and  $R_{3DR}$  can also be added (Figure 7) to affect the -3dB frequency and 3D magnitude.

(1)

(2)



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(6)





$f_{3DL(-3dB)} = 1 / 2\pi * (20k\Omega + R_{3DL}) * C_{3DL}$	(3)
$f_{3DR(-3dB)} = 1 / 2\pi * 20k\Omega + R_{3DR}) * C_{3DR}$	(4)

 $\Delta AV$  (change in AC gain) = 1 / 1 + M, where M represents some ratio of the nominal internal resistor,  $20k\Omega$  (see example below).

$f_{3dB} (3D) = 1 / 2\pi (1 + M)(20k\Omega * C_{3D})$	(5)
---	-----

 $C_{Equivalent}$  (new) =  $C_{3D}$  / 1 + M

#### **Table 9. Pole Locations**

R <sub>3D</sub> (kΩ) (optional)	C <sub>3D</sub> (nF)	М	ΔAV (dB)	f-3dB (3D) (Hz)	Value of C <sub>3D</sub> to keep same pole location (nF)	new Pole Location (Hz)
0	68	0	0	117		
1	68	0.05	-0.4	111	64.8	117
5	68	0.25	-1.9	94	54.4	117
10	68	0.50	-3.5	78	45.3	117
20	68	1.00	-6.0	59	34.0	117

## PCB LAYOUT AND SUPPLY REGULATION CONSIDERATIONS FOR DRIVING 8Ω LOAD

Power dissipated by a load is a function of the voltage swing across the load and the load's impedance. As load impedance decreases, load dissipation becomes increasingly dependent on the interconnect (PCB trace and wire) resistance between the amplifier output pins and the load's connections. Residual trace resistance causes a voltage drop, which results in power dissipated in the trace and not in the load as desired. For example,  $0.1\Omega$  trace resistance reduces the output power dissipated by an  $8\Omega$  load from 158.3mW to 156.4mW. The problem of decreased load dissipation is exacerbated as load impedance decreases. Therefore, to maintain the highest load dissipation and widest output voltage swing, PCB traces that connect the output pins to a load must be as wide as possible.

Poor power supply regulation adversely affects maximum output power. A poorly regulated supply's output voltage decreases with increasing load current. Reduced supply voltage causes decreased headroom, output signal clipping, and reduced output power. Even with tightly regulated supplies, trace resistance creates the same effects as poor supply regulation. Therefore, making the power supply traces as wide as possible helps maintain full output voltage swing.



(8)

(9)

(11)

(12)

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#### POWER DISSIPATION AND EFFICIENCY

In general terms, efficiency is considered to be the ratio of useful work output divided by the total energy required to produce it with the difference being the power dissipated, typically, in the IC. The key here is "useful" work. For audio systems, the energy delivered in the audible bands is considered useful including the distortion products of the input signal. Sub-sonic (DC) and super-sonic components (>22kHz) are not useful. The difference between the power flowing from the power supply and the audio band power being transduced is dissipated in the LM4947 and in the transducer load. The amount of power dissipation in the LM4947 is very low. This is because the ON resistance of the switches used to form the output waveforms is typically less than  $0.25\Omega$ . This leaves only the transducer load as a potential "sink" for the small excess of input power over audio band output power. The LM4947 dissipates only a fraction of the excess power requiring no additional PCB area or copper plane to act as a heat sink.

The LM4947 also has a pair of single-ended amplifiers driving stereo headphones,  $R_{HP}$  and  $L_{HP}$ . The maximum internal power dissipation for  $R_{HP}$  and  $L_{HP}$  is given by equation (9) and (10). From Equations (9) and (10), assuming a 5V power supply and a 32 $\Omega$  load, the maximum power dissipation for  $L_{HP}$  and  $R_{HP}$  is 40mW, or 80mW total.

$$P_{DMAX-LHP} = (V_{DD})^2 / (2\pi^2 R_L): Single-ended Mode$$
(7)

 $P_{DMAX-RHP} = (V_{DD})^2 / (2\pi^2 R_L)$ : Single-ended Mode

The maximum internal power dissipation of the LM4947 occurs when all 3 amplifiers pairs are simultaneously on; and is given by Equation (11).

 $P_{DMAX-TOTAL} = P_{DMAX-SPKROUT} + P_{DMAX-LHP} + P_{DMAX-RHP}$ 

The maximum power dissipation point given by Equation (11) must not exceed the power dissipation given by Equation (12):

$$P_{DMAX} = (T_{JMAX} - T_A) / \theta_{JA}$$
(10)

The LM4947's  $T_{JMAX} = 150^{\circ}$ C. In the ITL package, the LM4947's  $\theta_{JA}$  is 65°C/W. At any given ambient temperature  $T_A$ , use Equation (12) to find the maximum internal power dissipation supported by the IC packaging. Rearranging Equation (12) and substituting  $P_{DMAX-TOTAL}$  for  $P_{DMAX'}$  results in Equation (13). This equation gives the maximum ambient temperature that still allows maximum stereo power dissipation without violating the LM4947's maximum junction temperature.

$$T_{A} = T_{JMAX} - P_{DMAX-TOTAL} \theta_{JA}$$

For a typical application with a 5V power supply and an  $8\Omega$  load, the maximum ambient temperature that allows maximum stereo power dissipation without exceeding the maximum junction temperature is approximately 104°C for the ITL package.

$$T_{JMAX} = P_{DMAX-TOTAL} \theta_{JA} + T_A$$

Equation (14) gives the maximum junction temperature  $T_{JMAX}$ . If the result violates the LM4947's 150°C, reduce the maximum junction temperature by reducing the power supply voltage or increasing the load resistance. Further allowance should be made for increased ambient temperatures.

The above examples assume that a device is a surface mount part operating around the maximum power dissipation point. Since internal power dissipation is a function of output power, higher ambient temperatures are allowed as output power or duty cycle decreases. If the result of Equation (11) is greater than that of Equation (12), then decrease the supply voltage, increase the load impedance, or reduce the ambient temperature. If these measures are insufficient, a heat sink can be added to reduce  $\theta_{JA}$ . The heat sink can be created using

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additional copper area around the package, with connections to the ground pin(s), supply pin and amplifier output pins. External, solder attached SMT heatsinks such as the Thermalloy 7106D can also improve power dissipation. When adding a heat sink, the  $\theta_{JA}$  is the sum of  $\theta_{JC}$ ,  $\theta_{CS}$ , and  $\theta_{SA}$ . ( $\theta_{JC}$  is the junction-to-case thermal impedance,  $\theta_{CS}$  is the case-to-sink thermal impedance, and  $\theta_{SA}$  is the sink-to-ambient thermal impedance). Refer to the Typical Performance Characteristics curves for power dissipation information at lower output power levels.

## POWER SUPPLY BYPASSING

As with any power amplifier, proper supply bypassing is critical for low noise performance and high power supply rejection. Applications that employ a 5V regulator typically use a 1µF in parallel with a 0.1µF filter capacitors to stabilize the regulator's output, reduce noise on the supply line, and improve the supply's transient response. However, their presence does not eliminate the need for a local 1.1µF tantalum bypass capacitance connected between the LM4947's supply pins and ground. Keep the length of leads and traces that connect capacitors between the LM4947's power supply pin and ground as short as possible. Connecting a 2.2µF capacitor, C<sub>B</sub>, between the BYPASS pin and ground improves the internal bias voltage's stability and improves the amplifier's PSRR. The PSRR improvements increase as the bypass pin capacitor value increases. Too large, however, increases turn-on time and can compromise the amplifier's click and pop performance. The selection of bypass capacitor values, especially C<sub>B</sub>, depends on desired PSRR requirements, click and pop performance (as explained in the section, Proper Selection of External Components), system cost, and size constraints.

## SELECTING EXTERNAL COMPONENTS

## Input Capacitor Value Selection

Amplifying the lowest audio frequencies requires high value input coupling capacitor ( $C_i$  in Figures 1 & 2). A high value capacitor can be expensive and may compromise space efficiency in portable designs. In many cases, however, the speakers used in portable systems, whether internal or external, have little ability to reproduce signals below 150Hz. Applications using speakers with this limited frequency response reap little improvement by using large input capacitor.

The internal input resistor ( $R_i$ ), nominal 20k $\Omega$ , and the input capacitor ( $C_i$ ) produce a high pass filter cutoff frequency that is found using Equation (15).

$$f_c = 1 / (2\pi R_i C_i)$$

As an example when using a speaker with a low frequency limit of 150Hz,  $C_i$ , using Equation (15) is  $0.053\mu$ F. The  $0.22\mu$ F  $C_i$  shown in Figure 1 allows the LM4947 to drive high efficiency, full range speaker whose response extends below 40Hz.

## Bypass Capacitor Value Selection

Besides minimizing the input capacitor size, careful consideration should be paid to value of  $C_B$ , the capacitor connected to the BYPASS bump. Since  $C_B$  determines how fast the LM4947 settles to quiescent operation, its value is critical when minimizing turn-on pops. The slower the LM4947's outputs ramp to their quiescent DC voltage (nominally  $V_{DD}/2$ ), the smaller the turn-on pop. Choosing  $C_B$  equal to  $1.0\mu$ F along with a small value of  $C_i$  (in the range of  $0.1\mu$ F to  $0.39\mu$ F), produces a click-less and pop-less shutdown function. As discussed above, choosing  $C_i$  no larger than necessary for the desired bandwidth helps minimize clicks and pops.  $C_B$ 's value should be in the range of 5 times to 7 times the value of  $C_i$ . This ensures that output transients are eliminated when power is first applied or the LM4947 resumes operation after shutdown.

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(13)



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#### **DEMO BOARD SCHEMATIC**



## **Revision History**

Rev	Date	Description
1.0	06/16/06	Initial release.
1.1	06/19/06	Changed the Class D Efficiency (n) on Typical limit (from 79 to 86) on the 5V specification table.
1.2	06/22/06	Added more Typ Perf curves.
1.3	07/18/06	Replaced some of the curves.
1.4	08/29/06	Text edits.
1.5	10/18/06	Edited micro SMD pkg drawing, Figure 1, and Figure 2. Changed I <sub>DDQ</sub> typical and limit values on the 3.3V and 5.0V specification table. Removed CMRR SE condition and changed typical values for CMRR BTL on 3.3V and 5.0V specification table. Changed Mute Attenuation typical value on 5.0V specification table.
1.6	03/02/07	Edited the 3.3V and 5V EC tables.
1.7	03/02/07	Composed (CONFIDENTIAL) D/S for customer (SAMSUNG).
1.8	09/06/07	Edited Table 4.
1.9	11/09/07	Text edits.



## PACKAGING INFORMATION

Orderable Device	Status	Package Type	•		Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Samples
	(1)		Drawing			(2)		(3)	(Requires Login)
LM4947TL/NOPB	ACTIVE	DSBGA	YZR	25	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	
LM4947TLX/NOPB	ACTIVE	DSBGA	YZR	25	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	

<sup>(1)</sup> The marketing status values are defined as follows:

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**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

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<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM4947TL/NOPB	DSBGA	YZR	25	250	178.0	8.4	2.69	2.69	0.76	4.0	8.0	Q1
LM4947TLX/NOPB	DSBGA	YZR	25	3000	178.0	8.4	2.69	2.69	0.76	4.0	8.0	Q1

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# PACKAGE MATERIALS INFORMATION

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM4947TL/NOPB	DSBGA	YZR	25	250	203.0	190.0	41.0
LM4947TLX/NOPB	DSBGA	YZR	25	3000	206.0	191.0	90.0

# YZR0025



B. This drawing is subject to change without notice.



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